## RM3182

## ARINC 429 Differential Line Driver

## Features

- Adjustable rise and fall times
- Adjustable output voltage swing
- Short circuit protected
- Output overvoltage protected
- Sync and clock enable inputs
- TTL and CMOS compatible inputs
- MIL-STD-883B types available
- 100 Kbits/second data rate


## Description

The RM3182 consists of a bus interface line driver circuit plus auxiliary gating and synchronization circuitry. Designed to address the ARINC 429 standard, the RM3182 has output rise and fall times adjustable by the selection of two external capacitor values, and the output voltage swing range can be adjusted through an externally applied VREF signal. The logic inputs as well as the sync control inputs are TTL-CMOS compatible. The device is constructed on a monolithic IC using a junction-isolated bipolar process. Sputtered SiCr resistors are used in the internal bias circuitry, providing stable internal bias currents. The RM3182 is available in 16-lead ceramic DIP and 28-pad LCC, and can be ordered with MIL-STD883B high reliability screening.

## Block Diagram



Notes:

1. $R_{L}$ and $C_{L}$ are external. Full load values are: $R_{L}=400 \Omega, C_{L}=0.03 \mu F$.
2. Pin numbers are for 16-lead DIP.

## Pin Assignments




## Absolute Maximum Ratings

| Parameter | Min. | Max. | Units |
| :--- | :---: | :---: | :---: |
| Supply Voltage (+Vs to -Vs) |  | 36 | V |
| V1 Voltage |  | +7 | V |
| VREF Voltage |  | +6 | V |
| Logic Input Voltage | -0.3 | $+\mathrm{VS}+0.3$ | V |
| Output Short Circuit Duration |  | See Note 1 |  |
| Output Overvoltage | -6.5 | +6.5 | V |
| Storage Temperature Range | -65 | +150 | ${ }^{\circ} \mathrm{C}$ |
| Operating Temperature Range (see Note 2) | -55 | +125 | ${ }^{\circ} \mathrm{C}$ |
| Lead Soldering Temperature (60 sec.) |  | +300 | ${ }^{\circ} \mathrm{C}$ |

## Notes:

1. Heatsinking may he required for output short circuit at $+125^{\circ} \mathrm{C}$.
2. Heatsinking may be required depending on load and signal frequencies

## Thermal Characteristics

(Still air, soldered into PC board)

|  | Sidebrazed DIP | LCC |
| :--- | :---: | :---: |
| Maximum Junction Temperature | $+175^{\circ} \mathrm{C}$ | $+175^{\circ} \mathrm{C}$ |
| Max. PD TA $<50^{\circ} \mathrm{C}$ | 1470 mW | 1040 mW |
| Thermal Resistance $\theta \mathrm{JC}$ | $25^{\circ} \mathrm{C} / \mathrm{W}$ | $25^{\circ} \mathrm{C} / \mathrm{W}$ |
| Thermal Resistance $\theta \mathrm{JA}$ | $85^{\circ} \mathrm{C} / \mathrm{W}$ | $120^{\circ} \mathrm{C} / \mathrm{W}$ |
| For TA $>50^{\circ} \mathrm{C}$ Derate at | $11.7 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ | $8.3 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ |

## Electrical Characteristics

$\left(\mathrm{VS}= \pm 15 \mathrm{~V}, \mathrm{~V}_{\mathrm{REF}}=\mathrm{V} 1=+5 \mathrm{~V}\right.$, PWR Enable $=0 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=$ open circuit, $\left.-55^{\circ} \mathrm{C} \leq \mathrm{T}_{\mathrm{A}} \leq+125^{\circ} \mathrm{C}\right)$

| Parameters | Test Conditlons | Min. | Typ. | Max. | Units |
| :--- | :--- | :---: | :---: | :---: | :---: |
| Positive Supply Current | Data Rate $=0$ to 100 Kbits/sec |  | 11 | 16 | mA |
| Negative Supply Current | Data Rate $=0$ to 100 Kbits/sec | -16 | -10 |  | mA |
| V1 Supply Current | Data Rate $=0$ to 100 Kbits/sec |  | 200 | 975 | $\mu \mathrm{~A}$ |
| VREF Supply Current | Data Rate $=0$ to 100 Kbits/sec | -1.0 | -0.4 | -0.15 | mA |
| Input Logic Level High |  | 2.0 |  |  | V |
| Input Logic Level Low |  |  |  | 0.5 | V |
| Output Voltage High | With Respect to Ground | 4.75 | 5.0 | 5.25 | V |
| Output Voltage Low | With Respect to Ground | -5.25 | -5.0 | -4.75 | V |
| Output Voltage Null | Both Data Input = Logic 0 | -250 | 0 | +250 | mV |
| Input Current High | VIN = 2.0V |  | 1 | 10 | $\mu \mathrm{~A}$ |
| Input Current Low | VIN = 0.5V | -20 | -1 |  | $\mu \mathrm{~A}$ |
| Output Short Circuit Current | Output in High State, to Gnd |  | -133 | -80 | mA |
| Output Short Circuit Current | Output in Low State, to Gnd | 80 | 133 |  | mA |
| Positive Supply Current | Output High and Shorted to Gnd |  |  | 150 | mA |
| Negative Supply Current | Output Low and Shorted to Gnd | -150 |  |  | mA |
| Input Capacitance ${ }^{1}$ |  |  | 5 | 15 | pF |

Note:

1. Guaranteed by design.

## Typical Power Dissipation Characteristics

$\left(\mathrm{VS}= \pm 15 \mathrm{~V}, \mathrm{~V} 1=\mathrm{V}\right.$ REF $=+5 \mathrm{~V}$, Pwr Enable $\left.=0 \mathrm{~V}, \mathrm{~T} \mathrm{~A}=+25^{\circ} \mathrm{C}\right)$

| Data Rate <br> (Kbits/sec) | Load | Positive <br> Supply <br> Current | Negative <br> Supply <br> Current | Pin V1 <br> Supply <br> Current | Internal <br> Power <br> Dissipatlon | Load <br> Power <br> Dissipatlon |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 to 100 | Open Circuit | 11 mA | -10 mA | $200 \mu \mathrm{~A}$ | 325 mW | 0 |
| 12.5 to 14 | Full Load $^{1}$ | 24 mA | -24 mA | $200 \mu \mathrm{~A}$ | 660 mW | 60 mW |
| 100 | Full Load $^{1}$ | 46 mA | -46 mA | $200 \mu \mathrm{~A}$ | 1000 mW | 325 mW |

Note:

1. $R L=400 \Omega, C L=0.03 \mu \mathrm{~F}$ (see Block Diagram).

## Principles of Operation

Each device consists of one differential driver and associated gating circuitry. The gating circuitry consists of clock and sync signal inputs which are ANDed with the two data inputs. See the block diagram and truth table. Three power supplies are required to operate the RM3182 in a typical ARINC 429 bus application: $+15 \mathrm{~V},-15 \mathrm{~V}$, and +5 V . The +5 V supply, in addition to powering the internal bus current regulator, provides a reference voltage that determines the output voltage swing. The differential output swing will equal 2 VREF . If a value of VREF other than +5 V is used, then a separate +5 V supply is required for pin V 1 .

Figure 1 depicts connections for the ARINC 429 application. The driver output impedance is nominally $75 \Omega$. With the Data(A) input at a logic high and Data (B) input at a logic
low, AOUT will swing to $+V_{\text {REF }}$ and BoUT will swing to VREF (constituting a logic high state). Reversing the data input states will cause AOUT to swing to -VREF and BOUT to + Vref. With both data input signals at a logic low state, the outputs will both swing to 0 V (output in null state).

The slew rate of the outputs, and consequently rise and fall times, can be adjusted through the selection of two external capacitor values. Typical values are $\mathrm{CA}_{\mathrm{A}}=\mathrm{CB}=75 \mathrm{pF}$ for high-speed operation ( $100 \mathrm{Kbits} / \mathrm{sec}$ ) and $\mathrm{CA}=\mathrm{CB}=500 \mathrm{pF}$ for low-speed operation ( 12.5 to $14 \mathrm{Kbits} / \mathrm{sec}$ ).

The device can be powered down by applying a logic high signal to the Power Enable pin. If the power down feature is not used, then the Power Enable pin should be tied directly to ground.


Figure 1. ARINC 429 Bus Application


Figure 1. Switching Waveforms

## Truth Table

| Sync | Clock | Data (A) | Data (B) | AOUT | BoUT | Comments |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| X | L | X | X | 0 V | 0 V | Null |
| L | X | X | X | 0 V | 0 V | Null |
| H | H | L | L | 0 V | 0 V | Null |
| H | H | L | H | $-\mathrm{V}_{R E F}$ | $+\mathrm{VREF}^{2}$ | Low |
| H | H | H | L | + VREF | $-\mathrm{VREF}^{2}$ | High |
| H | H | H | H | 0 V | 0 V | Null |

## Mechanical Dimensions

## 16-Lead Sidebraze DIP

| Symbol | Inches |  | Millimeters |  | Notes |
| :--- | :---: | :---: | :---: | :---: | :---: |
|  | Min. | Max. | Min. | Max. |  |
| A | - | .200 | - | 5.08 |  |
| b 1 | .014 | .023 | .36 | .58 | 7 |
| b 2 | .045 | .065 | 1.14 | 1.65 | 2 |
| c 1 | .008 | .015 | .20 | .38 | 7 |
| D | - | .860 | - | 21.84 |  |
| E | .280 | .310 | 7.11 | 7.87 |  |
| e | .100 BSC |  | 2.54 BSC | 4,8 |  |
| eA | .300 BSC |  | 7.62 BSC | 6 |  |
| L | .125 | .200 | 3.18 | 5.08 |  |
| L 1 | .140 | - | 3.56 | - |  |
| Q | .015 | .070 | .38 | 1.78 | 3 |
| s 1 | .005 | - | .13 | - | 5 |
| s 2 | .005 | - | .13 | - |  |

## Notes:

1. Index area: a notch or a pin one identification mark shall be located adjacent to pin one. The manufacturer's identification shall not be used as pin one identification mark.
2. The minimum limit for dimension "b2" may be $.023(.58 \mathrm{~mm})$ for leads number $1,8,9$ and 16 only.
3. Dimension "Q" shall be measured from the seating plane to the base plane.
4. The basic pin spacing is $.100(2.54 \mathrm{~mm})$ between centerlines. Each pin centerline shall be located within $\pm .010(.25 \mathrm{~mm})$ of its exact longitudinal position relative to pins 1 and 16.
5. Applies to all four corners (leads number 1, 8, 9, and 16).
6. "eA" shall be measured at the centerline of the leads.
7. All leads - Increase maximum limit by .003 (.08mm) measured at the center of the flat, when lead finish applied.
8. Fourteen spaces.


## Mechanical Dimensions (continued)

## 28 Terminal Leadless Chip Carrier (LCC)

| Symbol | Inches |  | Millimeters |  | Notes |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min. | Max. | Min. | Max. |  |
| A | . 060 | . 100 | 1.52 | 2.54 | 3, 6 |
| A1 | . 050 | . 088 | 1.27 | 2.24 | 3, 6 |
| B1 | . 022 | . 028 | . 56 | . 71 | 2 |
| B3 | . 006 | . 022 | . 15 | . 56 | 2, 5 |
| D/E | . 442 | . 460 | 11.23 | 11.68 |  |
| D1/E1 | . 300 BSC |  | 7.62 BSC |  |  |
| D2/E2 | . 150 BSC |  | 3.81 BSC |  |  |
| e | . 050 BSC |  | 1.27 BSC |  |  |
| h | . 040 REF |  | 1.02 REF |  | 4 |
| j | . 020 REF |  | . 51 REF |  | 4 |
| L1 | . 045 | . 055 | 1.14 | 1.40 |  |
| L2 | . 075 | . 095 | 1.91 | 2.41 |  |
| L3 | . 003 | . 015 | . 08 | . 38 | 5 |
| ND/NE | 7 |  | 7 |  |  |
| N | 28 |  | 28 |  |  |

## Notes:

1. The index feature for terminal 1 identification, optical orientation or handling purposes, shall be within the shaded index areas shown on planes 1 and 2. Plane 1 terminal 1 identification may be an extension of the length of the metallized terminal which shall not be wider than the B1 dimension.
2. Unless otherwise specified, a minimum clearance of .015 inch ( 0.38 mm ) shall be maintained between all metallized features (e.g., lid, castellations, terminals, thermal pads, etc.).
3. Dimension " $A$ " controls the overall package thickness. The maximum " A " dimension is the package height before being solder dipped.
4. The corner shape (square, notch, radius, etc.) may vary at the manufacturer's option, from that shown on the drawing. The index corner shall be clearly unique.
5. Dimension "B3" minimum and "L3" minimum and the appropriately derived castellation length define an unobstructed three dimensional space traversing all of the ceramic layers in which a castellation was designed. Dimension "B3" maximum and "L3" maximum define the maximum width and depth of the castellation at any point on its surface. Measurement of these dimensions may be made prior to solder dripping.
6. Chip carriers shall be constructed of a minimum of two ceramic layers.



DETAIL "A"

## Ordering Information

| Part Number | Package | Operating Temperature Range |
| :--- | :---: | :---: |
| RM3182S | S | $-55^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |
| RM8182S/883B | S | $-55^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |
| RM3182L | L | $-55^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |
| RM3182L/883B | L | $-55^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |

## Notes:

/883B suffix denotes MIL-STD-883, Level B processing
S = 16 Lead sidebraze ceramic DIP
$L=28$ Terminal Leadless Chip Carrier

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